

Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 07977-023002	Application No. 08/907,182
Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Yamazaki, et al.	
		Filing Date August 6, 1997	Group Art Unit 1753

U.S. Patent Documents

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA						
	AB						
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	AH						
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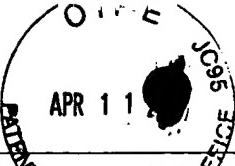
Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation <input checked="" type="checkbox"/> Yes <input type="checkbox"/> No
	AL						
	AM						
	AN						
	AO						
	AP						

Other Documents (include Author, Title, Date, and Place of Publication)

Examiner Initial	Desig. ID	Document
ADR	AQ	Nakame, M. et al. "Reduction of phosphorous gettering temperature with back side mechanical damage." Ext. Abst. Ecs. Fall Meeting, Vol. 181-2 (1981): 967-968.
	AR	
	AS	
	AT	

Examiner Signature	Date Considered
<i>Alan Dard</i>	5/8/03
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Sheet 1 of 1

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U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
ADD	AA	6,475,840 B1	11/5/2002	Miyanaga, et al.	438	166	
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